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Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	650					
R _{DS(on)} (Ω)	V _{GS} = 10 V	2.9				
Q _g (Max.) (nC)	48					
Q _{gs} (nC)	12					
Q _{gd} (nC)	19					
Configuration	Single					

FEATURES

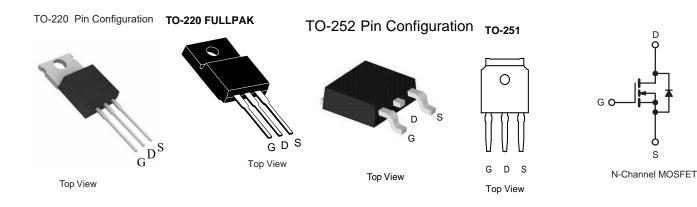
• Low Gate Charge Q_g Results in Simple Drive Requirement



RoHS

COMPLIANT

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC



ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted								
PARAMETER			SYMBOL	LIMIT	UNIT			
Drain-Source Voltage			V _{DS}	650	V			
Gate-Source Voltage			V _{GS}	± 30	V			
Continuous Drain Current ^e	λ of 10 λ	T _C = 25 °C	- I _D -	4				
Continuous Drain Current	V _{GS} at 10 V	$T_C = 100 ^{\circ}C$		3.2	А			
Pulsed Drain Current ^a			I _{DM}	21				
Linear Derating Factor				0.48	W/°C			
Single Pulse Avalanche Energy ^b			E _{AS}	325	mJ			
Repetitive Avalanche Current ^a			I _{AR}	4	A			
Repetitive Avalanche Energy ^a			E _{AR}	6	mJ			
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	60	W			
Peak Diode Recovery dV/dt ^c			dV/dt	2.8	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C			
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300				
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in			
				1.1	N·m			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting $T_J = 25 \text{ °C}$, L = 24 mH, $R_G = 25 \Omega$, $I_{AS} = 3.2 \text{ A}$ (see fig. 12).

- c. $I_{SD} \le 3.2$ Å, $dI/dt \le 90$ Å/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



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DADAMETED	TINGS SYMBOL	TVD		MAY				
PARAMETER		TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	- 65			°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-						
SPECIFICATIONS $T_J = 25 \text{ °C},$	unless other	wise noted						
PARAMETER	SYMBOL			ONS	MIN.	TYP.	MAX.	UNIT
Static						•		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 2	50 µA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Referenc	Reference to 25 °C, I _D = 1 mA ^d		-	670	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 \	V	-	-	± 100	nA
Zana Oata Maltana Dasia Oversant	I _{DSS}	$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	
Zero Gate Voltage Drain Current		V _{DS} = 520 V	′, V _{GS} = 0 V	-	-	250	μA	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D :	= 3.1 A ^b	-	-	2.9	Ω
Forward Transconductance	g _{fs}	V _{DS}	= 50 V, I _D =	3.1 A	3.9	-	-	S
Dynamic								
Input Capacitance	Ciss	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	1417	-		
Output Capacitance	C _{oss}			-	177	-		
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		-	7.0	-	
Output Capacitance	C		V _{DS} = 1.0	V, f = 1.0 MHz	-	1912	-	– pF
Oulput Capacitance	C _{oss}	$V_{GS} = 0 V$	= 0 V V _{DS} = 520 V, f = 1.0 MH	0 V, f = 1.0 MHz	-	48	-	
Effective Output Capacitance	Coss eff.		$V_{DS} = 0$	0 V to 520 V ^c	-	84	-	
Total Gate Charge	Qg		I _D = 3.2 A, V _{DS} = 400 V	-	-	48	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	12		
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	-		19
Turn-On Delay Time	t _{d(on)}				-	14	-	
Rise Time	t _r		= 325 V, I _D =		-	20	-	1
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 9.1 \Omega, R_{D} = 62 \Omega,$ see fig. 10 ^b		-	34	-	- ns	
Fall Time	t _f			-	18	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	showing the			-	-	4	^
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode			-	-	21	A
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 3.2 \text{ A}, V_{GS} = 0 \text{ V}^{b}$			-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 %0 1			-	493	739	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 3.2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$			-	2.1	3.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.

c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .

d. t = 60 s, f = 60 Hz.

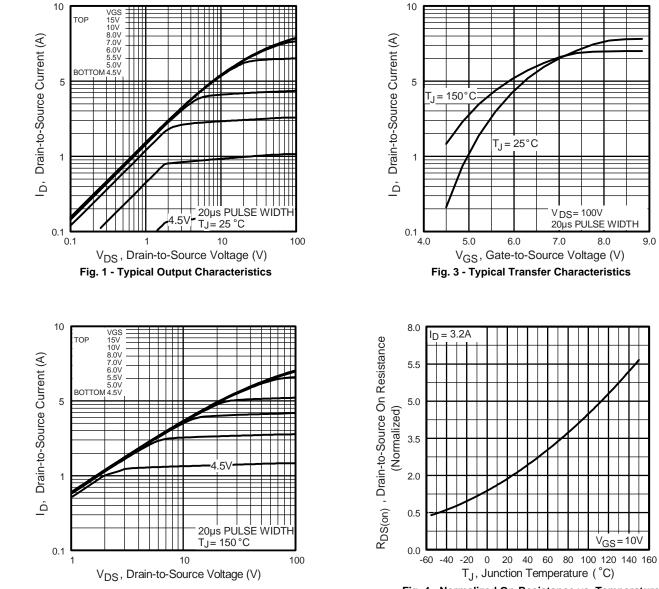


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8.0

 $V_{GS} = 10V$

9.0



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 2 - Typical Output Characteristics

Fig. 4 - Normalized On-Resistance vs. Temperature



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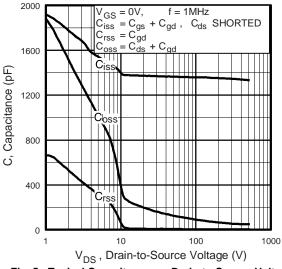


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

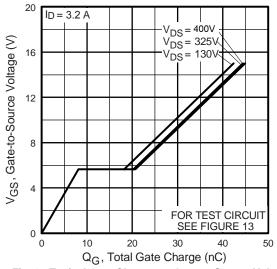


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

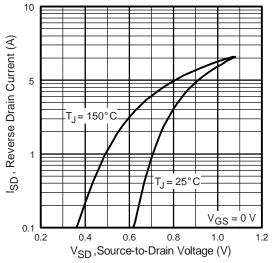
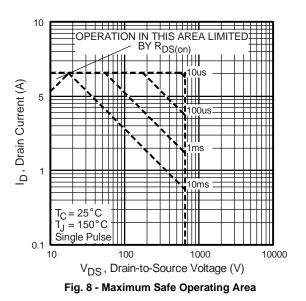


Fig. 7 - Typical Source-Drain Diode Forward Voltage





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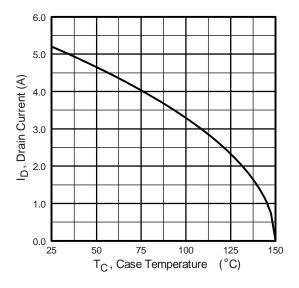


Fig. 9 - Maximum Drain Current vs. Case Temperature

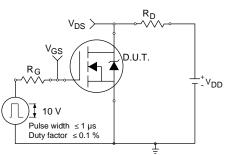


Fig. 10a - Switching Time Test Circuit

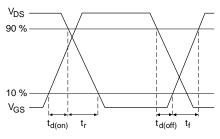
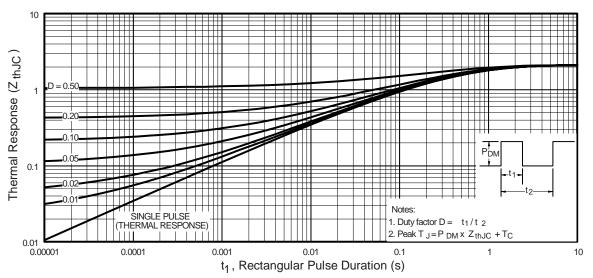


Fig. 10b - Switching Time Waveforms





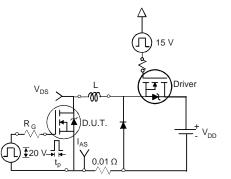
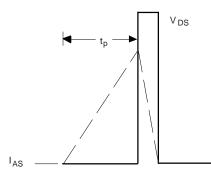
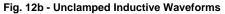


Fig. 12a - Unclamped Inductive Test Circuit







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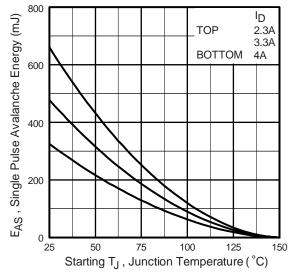


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

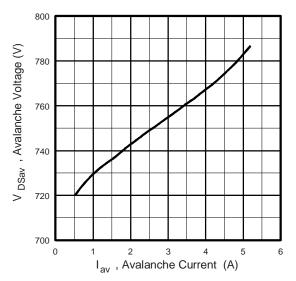


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

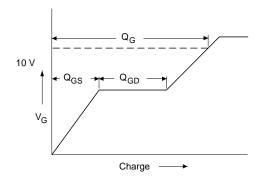


Fig. 13a - Basic Gate Charge Waveform

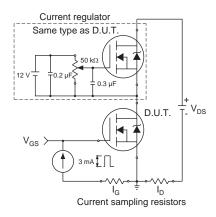
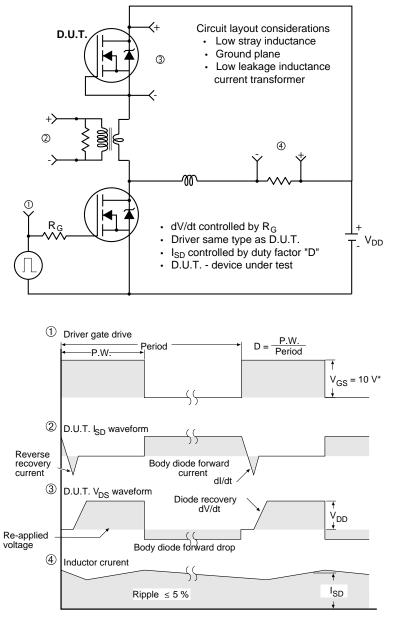


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



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